

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 09/821,081 | Applicant(s)/Patent Under Reexamination BENANTAR ET AL. | |
| | Examiner Minh Dieu Nguyen | Art Unit 2137 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-2002/0035686 | 03-2002 | Creighton et al. | 713/156 |
| | B | US-6,535,978 | 03-2003 | Padgett et al. | 713/156 |
| | C | US-6,671,805 | 12-2003 | Brown et al. | 713/176 |
| | D | US-2002/0010745 | 01-2002 | Schneider, Eric | 709/206 |
| | E | US-6,571,221 | 05-2003 | Stewart et al. | 705/52 |
| | F | US-6,134,658 | 10-2000 | Multerer et al. | 713/175 |
| | G | US-6,651,166 | 11-2003 | Smith et al. | 713/150 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.